

RoHS Compliant Product  
A suffix of "-C" specifies halogen & lead-free

## DESCRIPTION

The SMG2305-C is the highest performance trench P-Ch MOSFETs with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the small power switching and load switch applications.

The SMG2305-C meet the RoHS and Green Product requirement with full function reliability approved.

## FEATURES

- Advanced High Cell Density Trench Technology
- Super Low Gate Charge

## MARKING

2305

## PACKAGE INFORMATION

Package	MPQ	Leader Size
SC-59	3K	7 inch

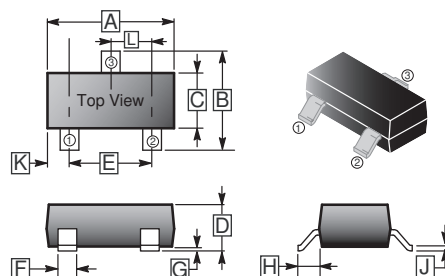
## ORDER INFORMATION

Part Number	Type
SMG2305-C	Lead (Pb)-free and Halogen-free

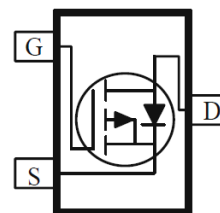
## ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Ratings		Unit	
		$\leq 10\text{sec}$	Steady State		
Drain-Source Voltage	$V_{DS}$	-20		V	
Gate-Source Voltage	$V_{GS}$	$\pm 12$		V	
Drain Current <sup>1</sup> , @ $V_{GS} = -10V$	$I_D$	$T_A = 25^\circ\text{C}$	-4.2	-3.7	A
		$T_A = 70^\circ\text{C}$	-3.5	-3	
Pulsed Drain Current <sup>3</sup>	$I_{DM}$	-30		A	
Power Dissipation	$P_D$	$T_A = 25^\circ\text{C}$	1.4		W
Operating Junction and Storage Temperature Range	$T_J, T_{STG}$	-55~150		$^\circ\text{C}$	
Thermal Resistance Data					
Thermal Resistance Junction-Ambient <sup>1</sup>	$R_{\theta JA}$	$\leq 10\text{sec}, 90$		$^\circ\text{C/W}$	
		Steady State, 125			
Thermal Resistance Junction-Ambient <sup>2</sup>		270			
Thermal Resistance Junction-Case <sup>1</sup>	$R_{\theta JC}$	80			

### SC-59



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	2.70	3.10	G	0.10	REF.
B	2.10	3.00	H	0.40	REF.
C	1.20	1.70	J	0.047	0.207
D	0.89	1.40	K	0.5	REF.
E	2.00	Typ.	L	0.95	REF.
F	0.30	0.50			



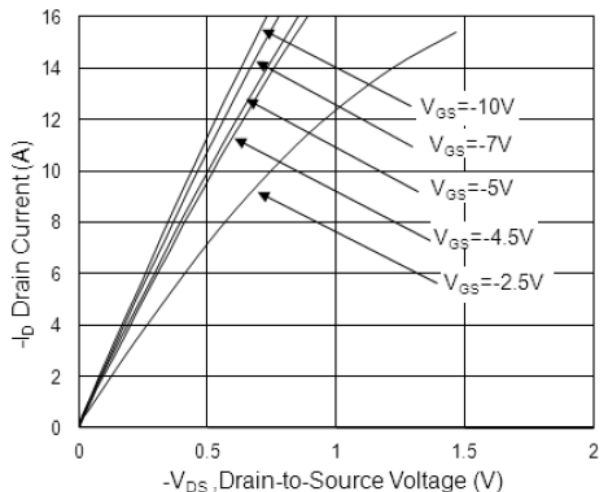
**ELECTRICAL CHARACTERISTICS** ( $T_J=25^\circ C$  unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions	
Drain-Source Breakdown Voltage	$BV_{DSS}$	-20	-	-	V	$V_{GS}=0, I_D = -250\mu A$	
Gate Threshold Voltage	$V_{GS(th)}$	-0.5	-	-1.2	V	$V_{DS}=V_{GS}, I_D = -250\mu A$	
Forward Transconductance	$g_{fs}$	-	5.6	-	S	$V_{DS} = -5V, I_D = -3A$	
Gate-Source Leakage Current	$I_{GSS}$	-	-	$\pm 100$	nA	$V_{GS} = \pm 12V$	
Drain-Source Leakage Current	$T_J=25^\circ C$	$I_{DSS}$	-	-	-1	$\mu A$	$V_{DS} = -20V, V_{GS}=0$
	$T_J=55^\circ C$		-	-	-5		$V_{DS} = -20V, V_{GS}=0$
Drain-Source On-Resistance <sup>4</sup>	$R_{DS(ON)}$	-	-	53	m $\Omega$	$V_{GS} = -10V, I_D = -4.5A$	
		-	-	65		$V_{GS} = -4.5V, I_D = -4.2A$	
		-	-	100		$V_{GS} = -2.5V, I_D = -2A$	
		-	-	250		$V_{GS} = -1.8V, I_D = -1A$	
Total Gate Charge	$Q_g$	-	11.9	-	nC	$I_D = -3A$ $V_{DS} = -15V$ $V_{GS} = -4.5V$	
Gate-Source Charge	$Q_{gs}$	-	1.8	-			
Gate-Drain ("Miller") Charge	$Q_{gd}$	-	3	-			
Turn-on Delay Time	$T_{d(on)}$	-	6.6	-	nS	$V_{DD} = -15V$ $V_{GS} = -4.5V$ $I_D = -3A$ $R_G = 3.3\Omega$ $R_L = 5\Omega$	
Rise Time	$T_r$	-	27.8	-			
Turn-off Delay Time	$T_{d(off)}$	-	46.2	-			
Fall Time	$T_f$	-	20.6	-			
Input Capacitance	$C_{iss}$	-	920	-	pF	$V_{GS}=0$ $V_{DS} = -15V$ $f=1MHz$	
Output Capacitance	$C_{oss}$	-	73	-			
Reverse Transfer Capacitance	$C_{rss}$	-	71	-			
<b>Source-Drain Diode</b>							
Forward on Voltage <sup>4</sup>	$V_{SD}$	-	-	-1.2	V	$I_S = -1.2A, V_{GS}=0$	
Continuous Source Current <sup>1</sup>	$I_S$	-	-	-3.7	A		
Pulsed Source Current <sup>3</sup>	$I_{SM}$	-	-	-15			

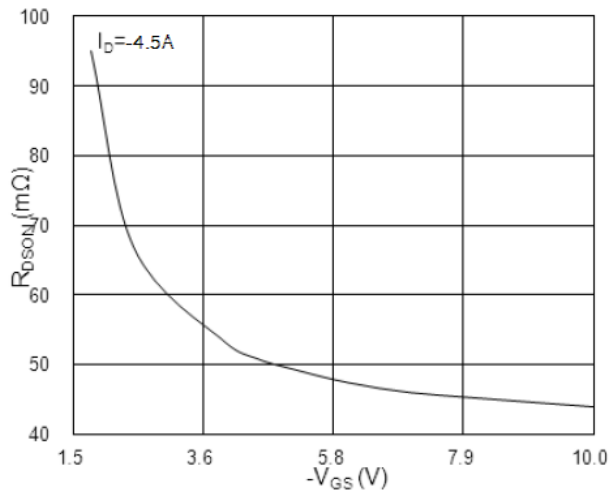
Notes:

- Surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- When mounted on Min. copper pad.
- Pulse width limited by maximum junction temperature.
- The data tested by pulsed, pulse width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$ .

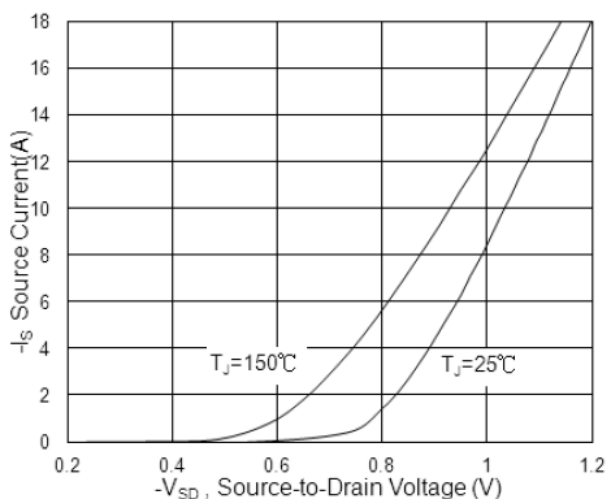
**CHARACTERISTIC CURVE**



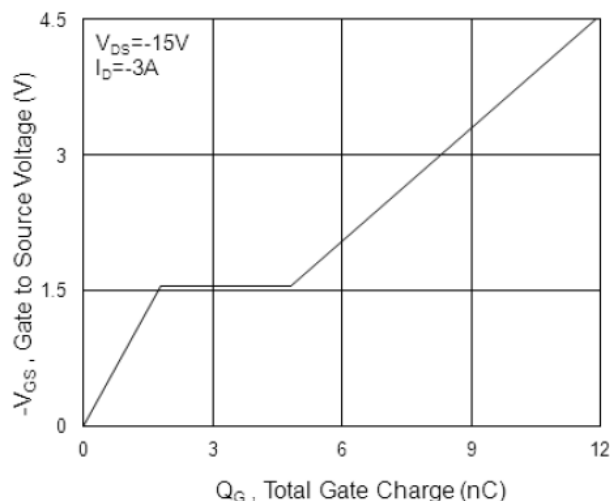
**Fig.1 Typical Output Characteristics**



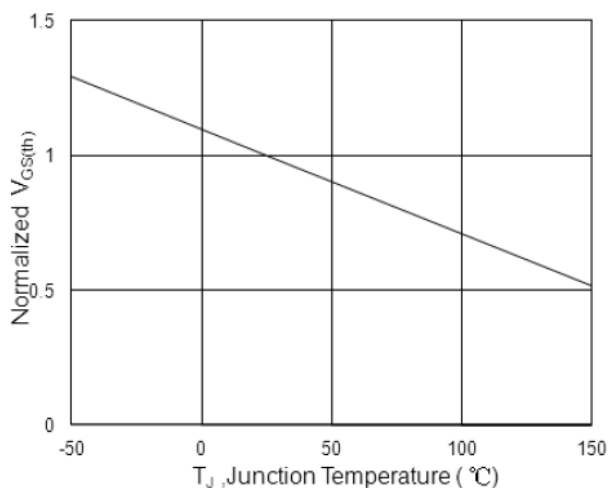
**Fig.2 On-Resistance vs. G-S Voltage**



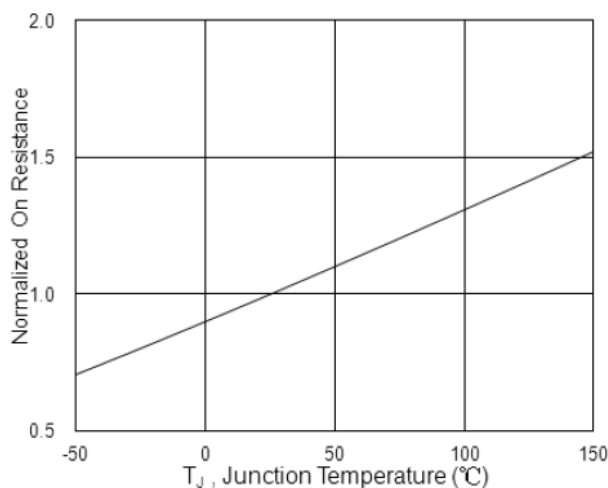
**Fig.3 Forward Characteristics Of Reverse**



**Fig.4 Gate-Charge Characteristics**

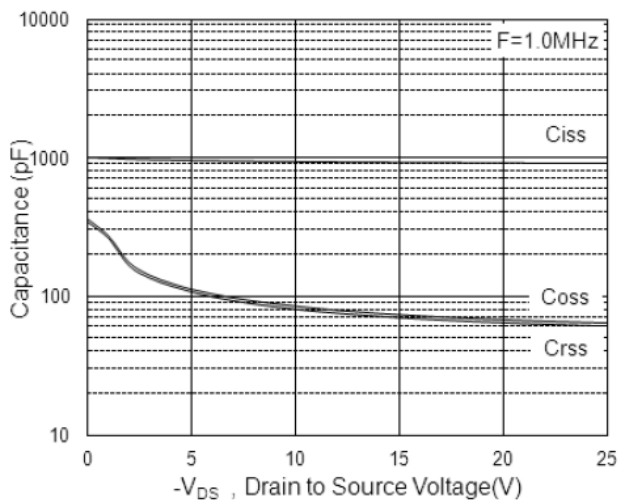


**Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$**

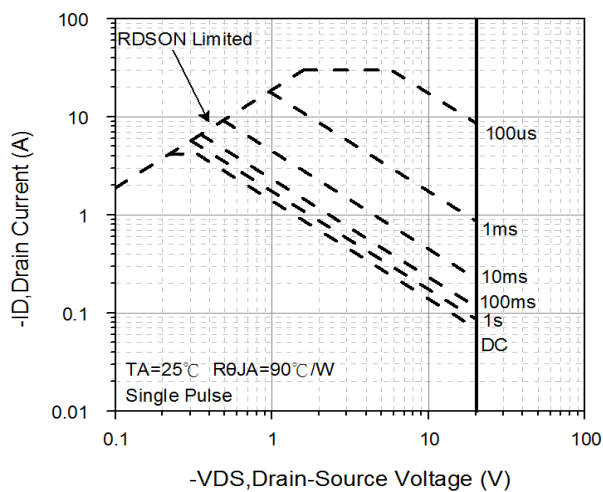


**Fig.6 Normalized  $R_{DS(ON)}$  vs.  $T_J$**

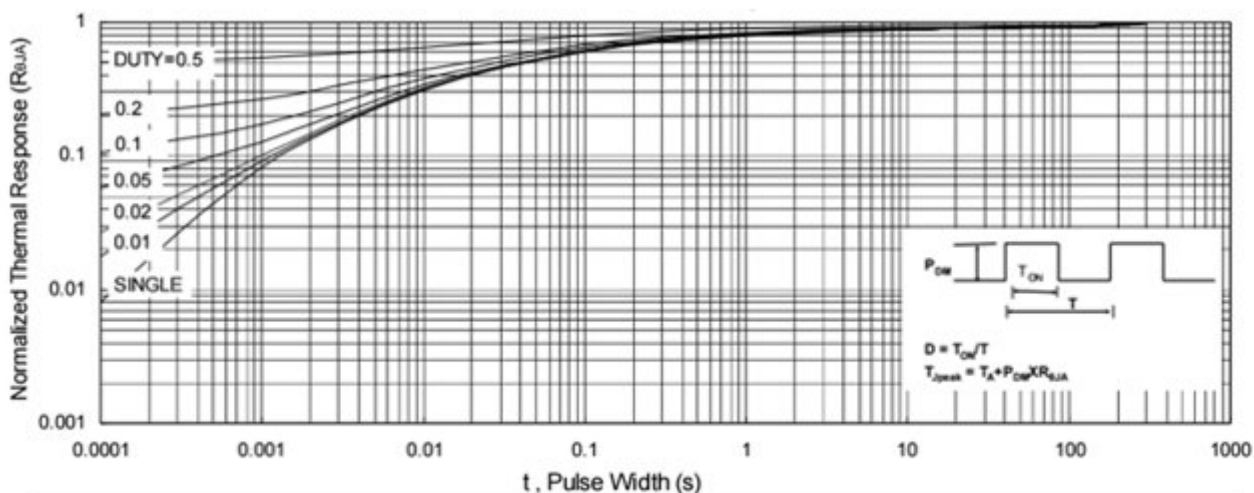
**CHARACTERISTIC CURVE**



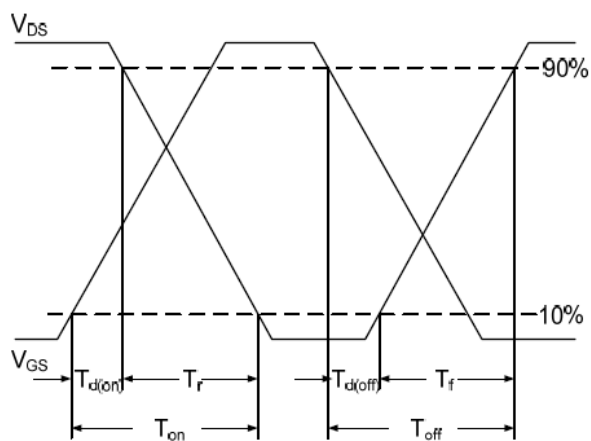
**Fig.7 Capacitance**



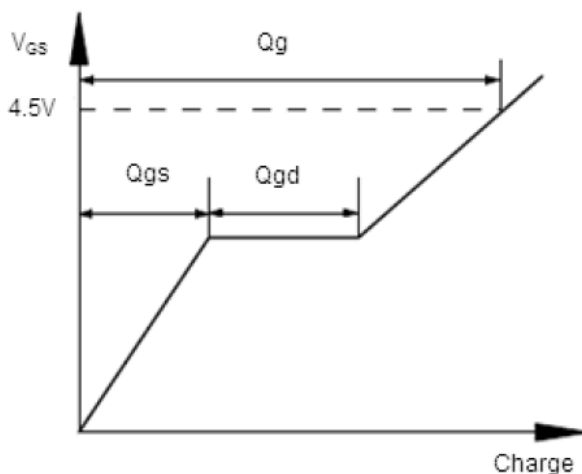
**Fig.8 Safe Operating Area**



**Fig.9 Normalized Maximum Transient Thermal Impedance**



**Fig.10 Switching Time Waveform**



**Fig.11 Gate Charge Waveform**